

Notice of References Cited

Application/Control No.

10/577,457

Applicant(s)/Patent Under
Reexamination
YAMANAKA, TAKAMITSU

Examiner

SWAPNEEL CHHAYA

Art Unit

2895

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,136,643	10-2000	Jeng et al.	438/253
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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